

IFNU424, IFNU425, IFNU426 Dual Matched N-Channel JFET

Features

- InterFET [N0001H Geometry](#)
- Low gate leakage: 750fA typical @20V
- Low Ciss: 3pF typical
- Typical noise: 2.0 nV/VHz
- Typical gain: 2mS
- Low cutoff voltage: -1.0 typical
- High radiation tolerance
- RoHS, REACH, CMR compliant
- Custom test and binning options available
- SMT, TH, and bare die package options
- Edge case SPICE modeling: [InterFET SPICE](#)

Industry Standard Crosses

- TBD

InterFET Similar Parts

- 2N4118-9A

InterFET Dual Parts

- IFNU421-2-3

Applications

- General: Amplifiers; Switches; Voltage regulators; Oscillators; Signal mixers; Noise generators
- Military/Aero: Radar; Communications; Satellites; Missiles guidance; Hydrophone Pre-Amps
- Medical: Medical imaging systems; Medical monitors and recorders; Ultrasound equipment
- Audio: Tone control circuits; Headphone amplifiers; Audio filters; Electret Microphone

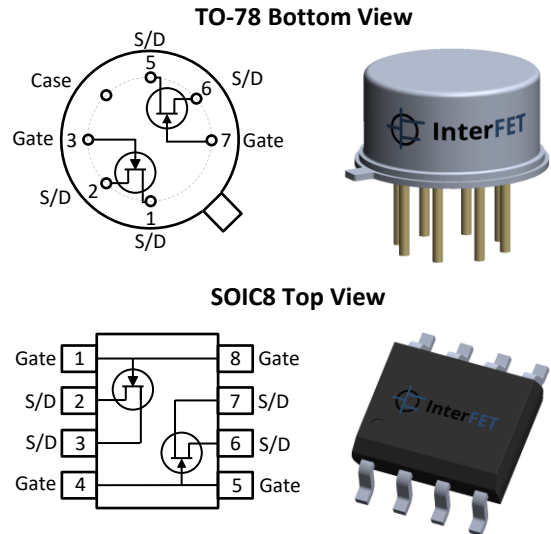
Description

The -40V InterFET IFNU424, IFNU425, and IFNU426 JFET's are targeted for ultra high input impedance applications for differential amplification and impedance matching. Gate leakages are less than 1pA at room temperatures. The TO-78 package is hermetically sealed and suitable for military applications. Custom specifications, matching, and packaging options are available.

Ordering Information

Part Number	Description	Case	Packaging
IFNU424; IFNU425; IFNU426	Through-Hole	TO-78	Bulk
SMPU424; SMPU425; SMPU426;	Surface Mount	SOIC8	Bulk
SMPU424TR; SMPU425TR; SMPU426TR	7" Tape and Reel: Max 500 Pieces 13" Tape and Reel: Max 2,500 Pieces	SOIC8	Minimum 500 Pieces Tape and Reel
IFNU424COT; IFNU425COT; IFNU426COT *	Chip Orientated Tray (COT Waffle Pack)	COT	70/Waffle Pack
IFNU424CFT; IFNU425CFT; IFNU426CFT *	Chip Face-up Tray (CFT Waffle Pack)	CFT	70/Waffle Pack

* Bare die packaged options are designed for matched specifications but not 100% tested



NOTE: S/D pins are interchangeable Source Drain connections



NOTICE: Please refer to the end of this document for information on product materials, compliance, safety, and legal statements.

Electrical Characteristics

Maximum Ratings (@ $T_A = 25^\circ\text{C}$, Unless otherwise specified)

Parameters	TO-71	SOIC-8	Unit
V_{RGS} Reverse Gate Source and Gate Drain Voltage	-20	-20	V
I_{FG} Continuous Forward Gate Current	50	50	mA
P_{D} Continuous Device Power Dissipation ¹	500	350	mW
P Power Derating ¹	3.3	2.8	mW/ $^\circ\text{C}$
T_{J} Operating Junction Temperature	-65 to 175	-55 to 150	$^\circ\text{C}$
T_{STG} Storage Temperature	-65 to 175	-55 to 150	$^\circ\text{C}$

¹ Thermal power dissipation and derating values obtained with gate pin (substrate) thermally connected to pad and/or internal layer.

Static Characteristics (@ $T_A = 25^\circ\text{C}$, Unless otherwise specified)

Parameters	Conditions	INFU424, INFU425, INFU426			Unit
		Min	Typ	Max	
$V_{(\text{BR})\text{GSS}}$ Gate to Source Breakdown Voltage	$I_{\text{G}} = -1\mu\text{A}, V_{\text{DS}} = 0\text{V}$	-40	-60		V
BV_{G1G2} Gate to Gate Breakdown Voltage	$I_{\text{G}} = -1\mu\text{A}, I_{\text{D}} = 0\text{A}, I_{\text{S}} = 0\text{A}$	± 40			V
I_{GSS} Gate to Source Reverse Current	$V_{\text{GS}} = -20\text{V}, V_{\text{DS}} = 0\text{V}, T_A = 25^\circ\text{C}$			-3	pA
	$V_{\text{GS}} = -20\text{V}, V_{\text{DS}} = 0\text{V}, T_A = 125^\circ\text{C}$			-3	nA
I_{G} Gate Operating Current	$V_{\text{DS}} = 10\text{V}, I_{\text{D}} = 30\mu\text{A}, T_A = 25^\circ\text{C}$			-0.5	pA
	$V_{\text{DS}} = 10\text{V}, I_{\text{D}} = 30\mu\text{A}, T_A = 125^\circ\text{C}$			-500	pA
$V_{\text{GS}(\text{OFF})}$ Gate to Source Cutoff Voltage	$V_{\text{DS}} = 10\text{V}, I_{\text{D}} = 1\text{nA}$	-0.4		-3	V
V_{GS} Gate Source Voltage	$V_{\text{DS}} = 10\text{V}, I_{\text{D}} = 30\mu\text{A}$			-2.9	V
I_{DSS} Drain to Source Saturation Current	$V_{\text{DS}} = 10\text{V}, V_{\text{GS}} = 0\text{V}$ (Pulsed)	60	1800		μA

Dynamic Characteristics (@ $T_A = 25^\circ\text{C}$, Unless otherwise specified)

Parameters	Conditions	INFU424, INFU425, INFU426			Unit
		Min	Typ	Max	
G_{FS} Forward Transconductance	$V_{\text{DS}} = 10\text{V}, V_{\text{GS}} = 0\text{V},$ $f = 1\text{kHz}$	100		1500	μS
G_{OS} Output Conductance	$V_{\text{DS}} = 10\text{V}, I_{\text{D}} = 30\mu\text{A}, f = 1\text{kHz}$			3	μS
C_{iss} Input Capacitance	$V_{\text{DS}} = 10\text{V}, V_{\text{GS}} = 0\text{V}, f = 1\text{MHz}$			3	pF
C_{rss} Reverse Capacitance	$V_{\text{DS}} = 10\text{V}, V_{\text{GS}} = 0\text{V}, f = 1\text{MHz}$			1.5	pF
e_{n} Equivalent Circuit Input Noise Voltage	$V_{\text{DS}} = 10\text{V}, I_{\text{D}} = 30\mu\text{A},$ $f = 10\text{Hz}$		20	70	$\text{nV}/\sqrt{\text{Hz}}$
NF Noise Figure	$V_{\text{DS}} = 10\text{V}, I_{\text{D}} = 30\mu\text{A},$ $f = 10\text{Hz}, R_{\text{G}} = 1\text{M}\Omega$			1	dB
$ V_{\text{GS1}} - V_{\text{GS2}} $ Differential Gate Source Voltage	$V_{\text{DS}} = 10\text{V}, I_{\text{D}} = 30\mu\text{A}$	INFU424		10	mV
		INFU425		15	
		INFU426		25	
$\frac{ V_{\text{GS1}} - V_{\text{GS2}} }{\Delta T}$ Differential Gate Source Voltage with Temperature	$V_{\text{DS}} = 10\text{V}, I_{\text{D}} = 30\mu\text{A}$ $T_A = -55^\circ\text{C}, T_B = 25^\circ\text{C},$ $T_C = 125^\circ\text{C}$	INFU424		1	$\text{mV}/^\circ\text{C}$
		INFU425		2.5	
		INFU426		5	
CMRR Common Mode Rejection Ratio	$V_{\text{DD}} = 10\text{V to } 20\text{V}, I_{\text{D}} = 30\mu\text{A}$	INFU424	90		dB
		INFU425	80		
		INFU426	80		



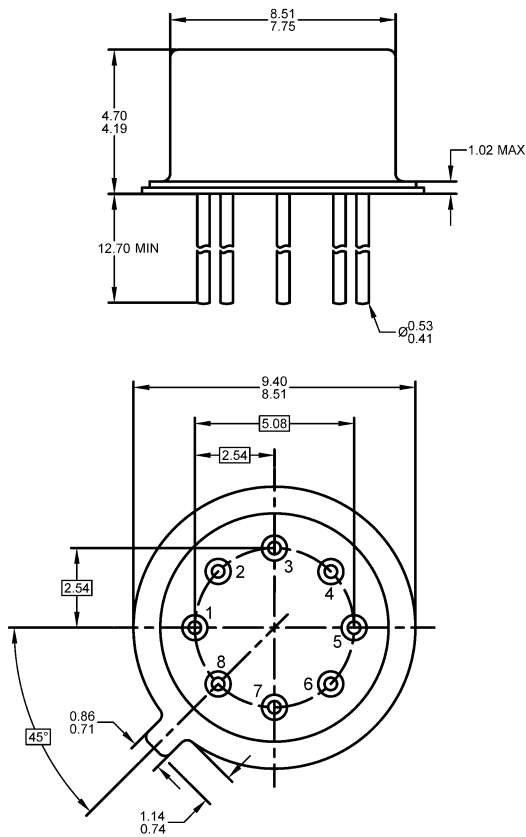
Typical IFNU424, IFNU425, IFNU426 Characteristics



Typical IFNU424, IFNU425, IFNU426 Characteristics (Continued)

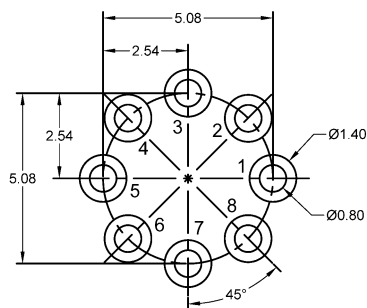
T0-78 Mechanical and Layout Data

Package Outline Data



1. All linear dimensions are in millimeters.
2. Eight leaded device. Not all leads are shown in drawing views.
3. Some package configurations will not populate pin 8 and/or pin 4.
4. Package weight approximately 0.44 grams
5. Bulk product is shipped in standard ESD shipping material
6. Refer to JEDEC standards for additional information.

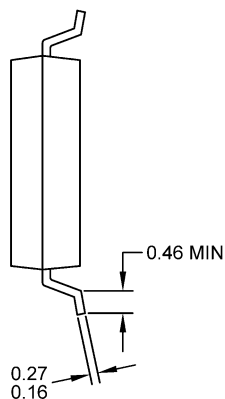
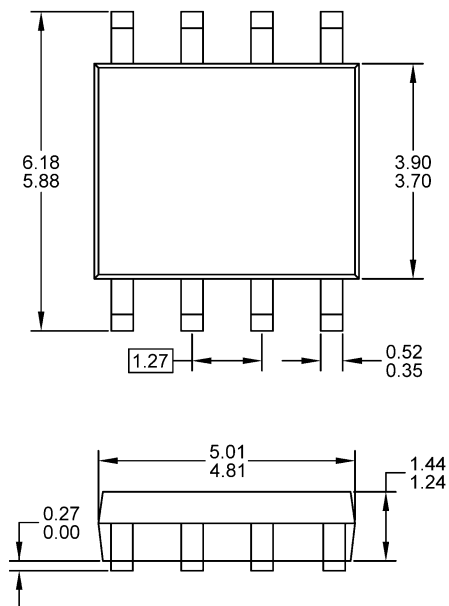
Suggested Through-Hole Layout



1. All linear dimensions are in millimeters.
2. Pads 8 and/or pad 4 can be eliminated for devices with less pins.
3. The suggested land pattern dimensions have been provided as an eight pin bent lead reference only. A more robust pattern may be desired for wave soldering or reduced pin count.

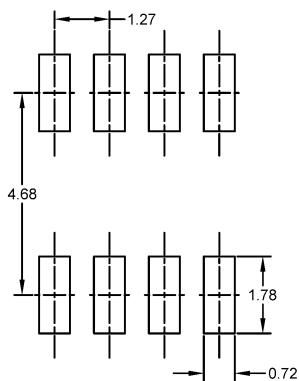
SOIC8 Mechanical and Layout Data

Package Outline Data



1. All linear dimensions are in millimeters.
2. Package weight approximately 0.21 grams
3. Molded plastic case UL 94V-0 rated
4. For Tape and Reel specifications refer to InterFET CTC-021 Tape and Reel Specification, Document number: IF39002
5. Bulk product is shipped in standard ESD shipping material
6. Refer to JEDEC standards for additional information.

Suggested Pad Layout



1. All linear dimensions are in millimeters.
2. The suggested land pattern dimensions have been provided for reference only. A more robust pattern may be desired for wave soldering.

Compliance and Legal

Environment

InterFET parts follow the latest RoHS Compliance, REACH Compliance, Proposition 65 Statement, TSCA Statement, and Chemical Disposal and Waste Mitigation requirement and guidelines. For more on InterFET's Environmental Commitment please visit

www.InterFET.com/environmental/.

Package materials

Parameters	SOT23	SOIC8	TO-92	Metal Case
Alloy	CDA194	C194 1/2H	C194 1/2H	Kovar
Cu	Balance	97% min	97% min	
Fe	2.1 – 2.6%	2.1 – 2.6%	2.1 – 2.6%	53%
Zn	0.05 – 0.2%	0.05 – 0.2%	0.05 – 0.15%	
P	0.015 – 0.15%	0.015 – 0.15%	0.015 – 0.15%	
Pb	0.03% max	0.03% max	0.03% max	
Ni				29%
Co				17%
Mn				0.3%
Si				0.2%
C				<0.01%
Au				Plating

Package tests

Parameters	SOT23	SOIC8	TO-92	Metal Case
MSL	Level 1	Level 2	N/A	N/A
ESD	Class M4 Machine Model Class 3A HBM	Class M4 Machine Model Class 3A HBM	Class M4 Machine Model Class 3A HBM	Class M4 Machine Model Class 3A HBM

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